

Center Mount Sample Holders

MEASURE

Reflectance	Powders
Transmittance	Liquids
Absorbance	Thin Films
Scatter	Solids

CSMH-RTC-CUV-SF



VALUE

- Holds standard 12.5 mm square cuvette
- Positions cuvette normal to incident beam optical axis in the center of the RT-060-SF Reflectance/Transmittance Sphere
- Holds a cuvette used for liquids and powders for transmittance, absorbance and scatter characterization
- Coated with Spectrafect® diffuse reflectance coating
- Integrated baffle screens sample from detector port

CSMH-RTC-CLIP-SF



VALUE

- Holds thin films up to 50 mm diameter
- Positions thin films in center of RTC-060-SF Reflectance/Transmittance Sphere
- Sample rotation 0 to 360°
- For multi-angle reflectance and transmittance measurements
- Coated with Spectrafect® diffuse reflectance coating
- Integrated baffle screens sample from detector port

CSMH-RTC-JAW-SF



VALUE

- Holds samples up to 50 mm diameter
- Positions samples in center of RTC-060-SF Reflectance/Transmittance Sphere
- Sample rotation 0 to 360°
- For multi-angle reflectance measurement
- Coated with Spectrafect® diffuse reflectance coating
- Integrated baffle screens sample from detector port

Specifications

Model Number	Part Number	Reflectance	Sample Size	Sample Rotation
CSMH-RTC-CUV-SF	AS-02728-000	98%	12.5 x 12.5 x 45 mm	Fixed
CSMH-RTC-CLIP-SF	AS-02759-000	98%	50 mm diameter	360°
CSMH-RTC-JAW-SF	AS-02486-000	98%	25 to 50 mm round or square	360°